Search Notes



·Application/Control No.

Applicant(s)/Patent under Reexamination

MYERS, MICHAEL H.

Art Unit

Examiner Jacob Meek

09/835,594

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SEARCHED				
Class	Subclass	Date	Examiner	
375	297,296, 261	5/6/2005	JM	
330	149,107	5/6/2005	JM	
330	136	5/6/2005	JM	
332	124,159	5/6/2005	JM	
455	115,126	5/6/2005	JM	
332	107	5/6/2005	JM	
455	91,127	5/6/2005	JM	
455	108	5/6/2005	JM	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
375	296	5/6/2005	JM		
455	114.3	5/6/2005	JM		

SEARCH NO (INCLUDING SEARC		·)
	DATE	EXMR
NPL: see search notes	5/5/2005	JM
East: see search notes	5/5/2005	JM
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